Notice of References Cited Application/Control No. 10/774,528 Applicant(s)/Patent Under Reexamination HASEGAWA ET AL Examiner David B. Thomas Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,383,063 B1	05-2002	Ohashi et al.	451/303
	В	US-6,354,920 B1	03-2002	Judge et al.	451/62
	С	US-5,616,070 A	04-1997	Rice et al.	451/62
	D	US-5,251,404 A	10-1993	Wasserbaech, Eberhard E.	451/303
	E	US-5,193,314 A	03-1993	Wormley et al.	451/5
	F	US-4,993,190 A	02-1991	Hiyoshi et al.	451/307
	G	US-4,833,834 A	05-1989	Patterson et al.	451/310
-	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2825652 A1	12-2002	France	BONACHERA et al.	B24B 05/42
	0	JP 08257889 A	10-1996	Japan	KIRIYAMA et al.	B24B 21/00
	P					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
	٧								
	w								
	х								

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.